

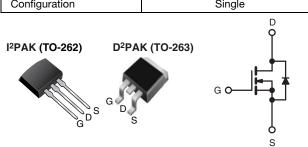


HALOGEN

FREE

Power MOSFET

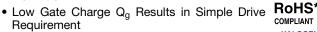
PRODUCT SUMMARY						
V _{DS} (V)	50	500				
R _{DS(on)} (Max.) (Ω)	V _{GS} = 10 V	V _{GS} = 10 V 3.0				
Q _g (Max.) (nC)	17	17				
Q _{gs} (nC)	4.5	4.3				
Q _{gd} (nC)	8.8	8.5				
Configuration	Sino	Single				

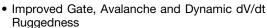


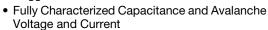
N-Channel MOSFET

FEATURES

• Halogen-free According to IEC 61249-2-21 **Definition**







- Effective Coss specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- · Half Bridge and Full Bridge

ORDERING INFORMATION						
Package	D ² PAK (TO-263)	I ² PAK (TO-262)				
Lead (Pb)-free and Halogen-free	SiHF820AS-GE3	SiHF820AL-GE3				
Load (Dh) fron	IRF820ASPbF	IRF820ALPbF				
Lead (Pb)-free	SiHF820AS-E3	SiHF820AL-E3				

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	500	V
Gate-Source Voltage			V_{GS}	± 30	V
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	L	2.5	
Continuous Diain Current	VGS at 10 V	T _C = 100 °C	ID	1.6	Α
Pulsed Drain Current ^{a, e}			I _{DM}	10	
Linear Derating Factor		0.4	W/°C		
Single Pulse Avalanche Energy ^{b, e}			E _{AS}	140	mJ
Avalanche Current ^a			I _{AR}	2.5	Α
Repetiitive Avalanche Energy ^a			E _{AR}	5.0	mJ
Maximum Power Dissipation	T _C =	25 °C	P_{D}	50	W
Peak Diode Recovery dV/dtc, e	dV/dt	3.4	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d	
Mounting Torque	6 22 or I	C 00 = 1 M0 = = 11		10	lbf ⋅ in
Mounting Torque	6-32 or M3 screw			1.1	N⋅m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting $T_J = 25$ °C, L = 45 mH, $R_g = 25$ Ω , $I_{AS} = 2.5$ A (see fig. 12).
- c. $I_{SD} \le 2.5 \text{ A}$, $dI/dt \le 270 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_{J} \le 150 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.
- e. Uses IRF820A, SiHF820A data and test conditions.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF820AS, SiHF820AS, IRF820AL, SiHF820AL

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THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient (PCB Mounted, steady-state) ^a	R _{thJA}	-	62	°C/W		
Maximum Junction-to-Case (Drain)	R_{thJC}	-	2.5			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		-			l		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	_s = 0, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA ^d	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.5	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	1	-	± 100	nA
Zara Cata Valta a Duais Comment		V _{DS} :	= 500 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.5 A ^b	1	-	3.0	Ω
Forward Transconductance	9fs	V _{DS} :	= 50 V, I _D = 1.5 A ^d	1.4	-	-	S
Dynamic						•	
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	340	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	-	53	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.	f = 1.0 MHz, see fig. 5 ^d		2.7	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz	-	490	-	
			V _{DS} = 400 V, f = 1.0 MHz	-	15	-	
Effective Output Capacitance	C _{oss} eff.	V _{DS} = 0 V to 400 V ^{c, d}		-	28	-	
Total Gate Charge	Qg	V _{GS} = 10 V		-	-	17	
Gate-Source Charge	Q _{gs}			-	-	4.3	nC
Gate-Drain Charge	Q_{gd}		oss ligi s alia is	-	-	8.5	
Turn-On Delay Time	t _{d(on)}			-	8.1	-	
Rise Time	t _r	V _{DD} =	= 250 V, I _D = 2.5 A,	-	12	-	
Turn-Off Delay Time	t _{d(off)}	$R_g = 21 \Omega$,	$R_D = 97 \Omega$, see fig. $10^{b, d}$	-	16	-	ns
Fall Time	t _f	1		-	13	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.5	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	10	
Body Diode Voltage	V_{SD}	T _J = 25 °C	V_{c} , $I_{S} = 2.5 \text{ A}$, $V_{GS} = 0 \text{ V}^{b}$	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 25 °C 1	- 2 E A dl/dt - 100 A/: ah d	-	330	500	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 2.5 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}, d}$		-	760	1140	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- d. Uses IRF820A/SiHF820A data and test conditions.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

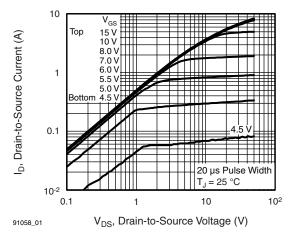


Fig. 1 - Typical Output Characteristics

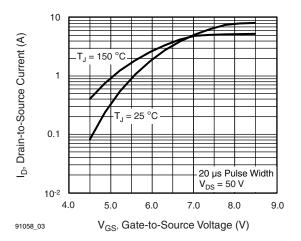


Fig. 3 - Typical Transfer Characteristics

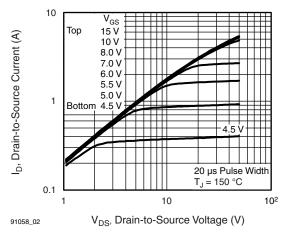


Fig. 2 - Typical Output Characteristics

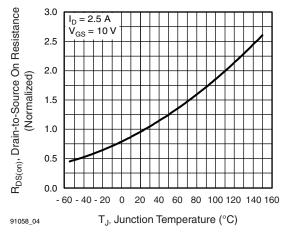


Fig. 4 - Normalized On-Resistance vs. Temperature



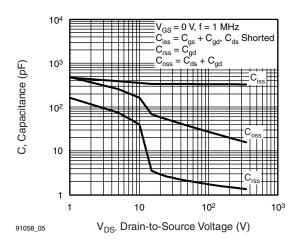


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

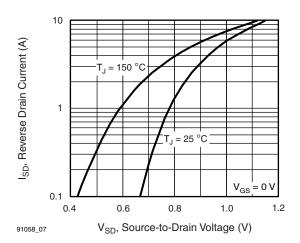


Fig. 7 - Typical Source-Drain Diode Forward Voltage

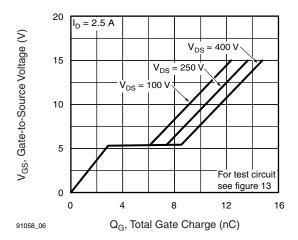


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

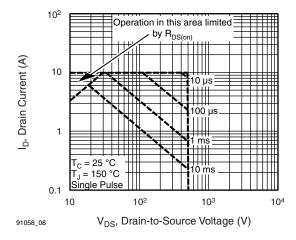


Fig. 8 - Maximum Safe Operating Area



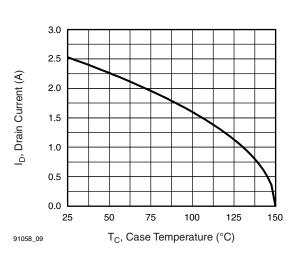


Fig. 9 - Maximum Drain Current vs. Case Temperature

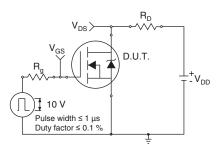


Fig. 10a - Switching Time Test Circuit

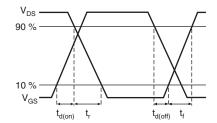


Fig. 10b - Switching Time Waveforms

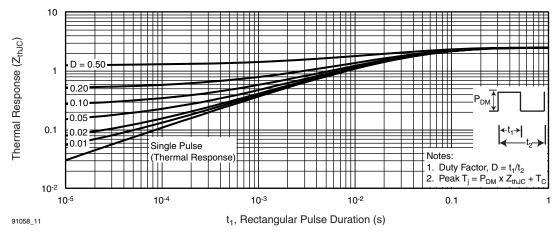


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

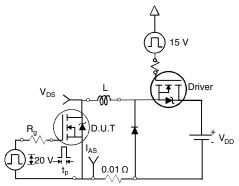


Fig. 12a - Unclamped Inductive Test Circuit

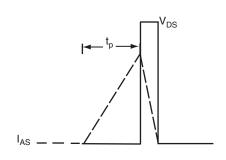


Fig. 12b - Unclamped Inductive Waveforms

IRF820AS, SiHF820AS, IRF820AL, SiHF820AL

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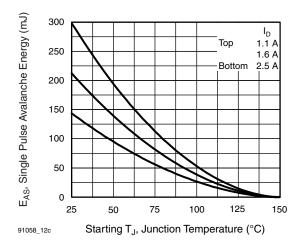


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

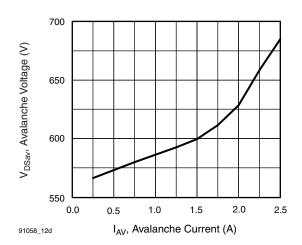


Fig. 12d - Basic Gate Charge Waveform

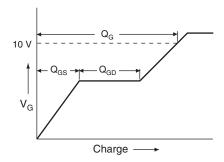


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

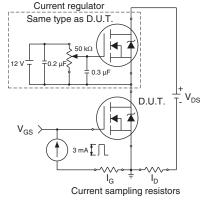
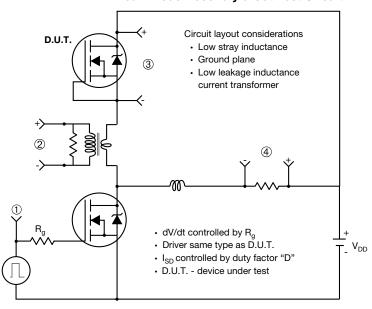


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



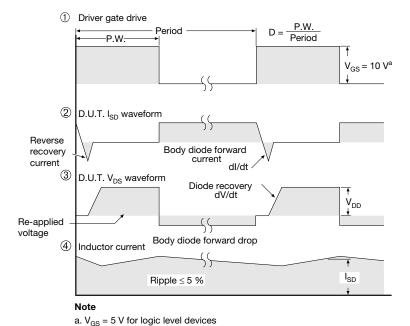


Fig. 14 - For N-Channel

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TO-263AB (HIGH VOLTAGE)







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	-E1-	₩	<u> </u>	7

	MILLIN	METERS	INC	HES
DIM.	MIN. MAX.		MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIN	METERS	INC	HES
DIM.	MIN.	MIN. MAX.		MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	i
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	i	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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